

Space Charge Effects on the Evolution of Gaussian Short-Pulse Beam Profiles

Yves Heri, Peng Zhang*

Michigan State University, Electrical and Computer Engineering, East Lansing, MI, USA *pz@egr.msu.edu



Summary

- We investigate **space charge effects** on the dynamics of Gaussian short pulse beam profile.
- We consider **short pulses** of different profiles for different charge densities and pulse widths.
- We analyze the electron sheet **phase-space trajectories** and pulse profile evolution

 during gap transit.

Multiple-Sheet Model

A one-dimensional (1D) planar diode with gap distance d and gap voltage V_q , with M sheets inside.

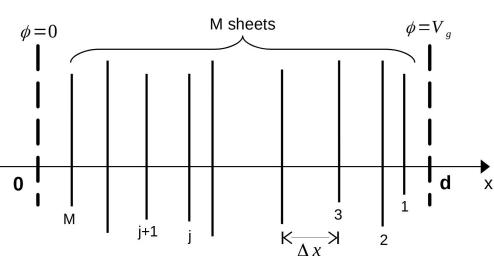


Figure 1: Sheet numbering inside the diode gap [1]

- Sheet j at position $\bar{x}_j = x_j/d$ has a normalized charge density $\bar{\rho}_j = \rho/\sigma_1$.
- The normalized electric field on sheet j is

$$\bar{E}_{j} = \frac{E_{j}}{E_{0}} = 1 + \left[\sum_{i=1}^{M} \bar{\rho}_{i} \bar{x}_{i} - \left(\sum_{i=1}^{j-1} \bar{\rho}_{i} + \frac{1}{2} \bar{\rho}_{j} \right) \right]$$
(1)

• The normalized Electric field at the cathode $(\bar{x}=0)$

$$\bar{E}_K = 1 + \sum_{i=1}^{M} \bar{\rho}_i (\bar{x}_i - 1)$$
 (2)

• The Space Charge Limited (SCL) charge density $\bar{\rho}_{j}^{*}$ is found for $\bar{E}_{K}=0$

$$1 + \sum_{i=1}^{M} \bar{\rho}_{j}^{*} (\bar{x}_{i} - 1) = 0$$
 (3)

Model Parameters

Symbol	Meaning	Formula/Value
E_0	Applied field	$-V_g/d$
σ_1	SCL density	$arepsilon_0 E_0$
$ au_p$	Pulse length	$[0.1, 1] \times T_0$
T_0	Transit time	$\sqrt{2d/\left(eE_{0}/m\right)}$
Δ	Distortion	$\delta ar{x}_{final}/\delta ar{x}_{init}$
J	Current density	$J = 3\sum_{i=1}^{M} \bar{\rho}_i \bar{v}_i$

Gaussian Pulse Profiles

• Sheet j has a charge density

$$\bar{\rho}_j = a \exp\left(-\frac{(j-\mu)^2}{b}\right) \tag{4}$$

where $\mu = (M+1)/2$, a and b are found by solving (3) with $\sum_{i=1}^{M} \bar{\rho}_{i}^{*} = 1$.

- We simulate for M=30 preloaded sheets, a=1/12.5, and b=50.
- The initial pulse intervals $\delta \bar{x} = \bar{x}_n \bar{x}_{n+1}$ are assumed to be uniform. $\delta x \approx (1/2)(eE_0/m)\tau_n^2$.

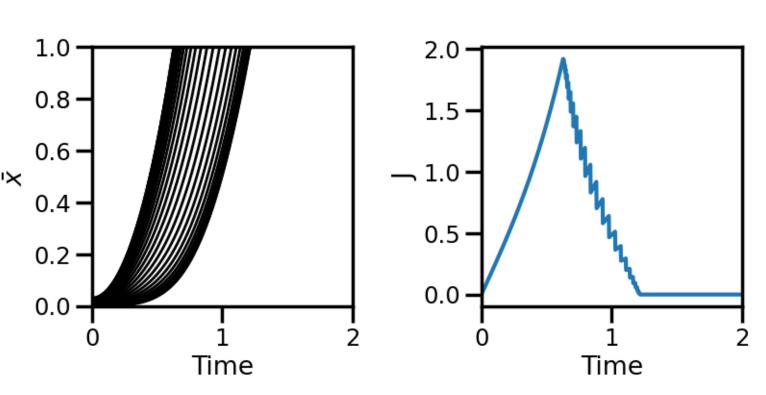


Figure 2: Sheets' trajectories & current density for T_0 and $\bar{\rho}^*$

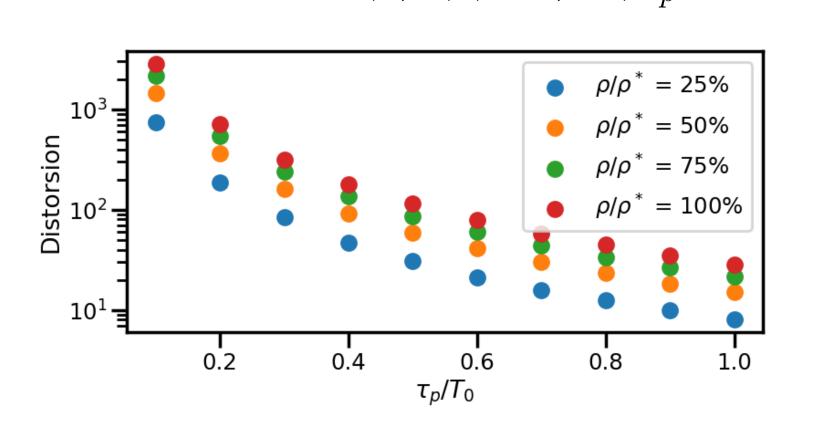


Figure 3: Gaussian profile distortion with initial pulse length

Comparison of pulse profiles

• We compare pulses of different charges and shapes.

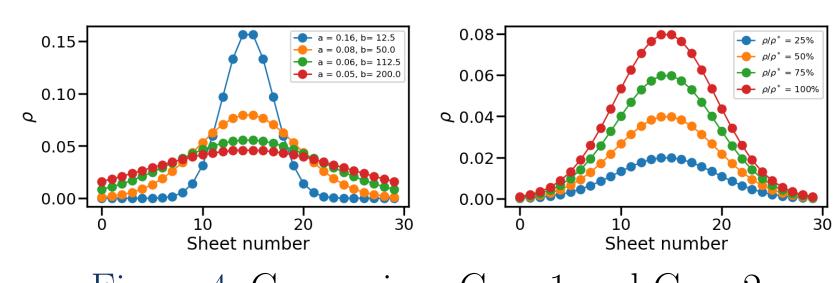


Figure 4: Comparison Case 1 and Case 2

Simulation details

- We simulate Gaussian pulses with M=30 preloaded sheets. We fixed $\delta \bar{x}=1/M^2=1/900$ and $\bar{x}_{30}=0$.
- Case 1: We maintain the total charge but vary the shape of the pulse.
- Case 2: We vary the total charge but keep the pulse shape unchanged.

Evolution of the Gaussian Pulse Profiles Inside the Gap

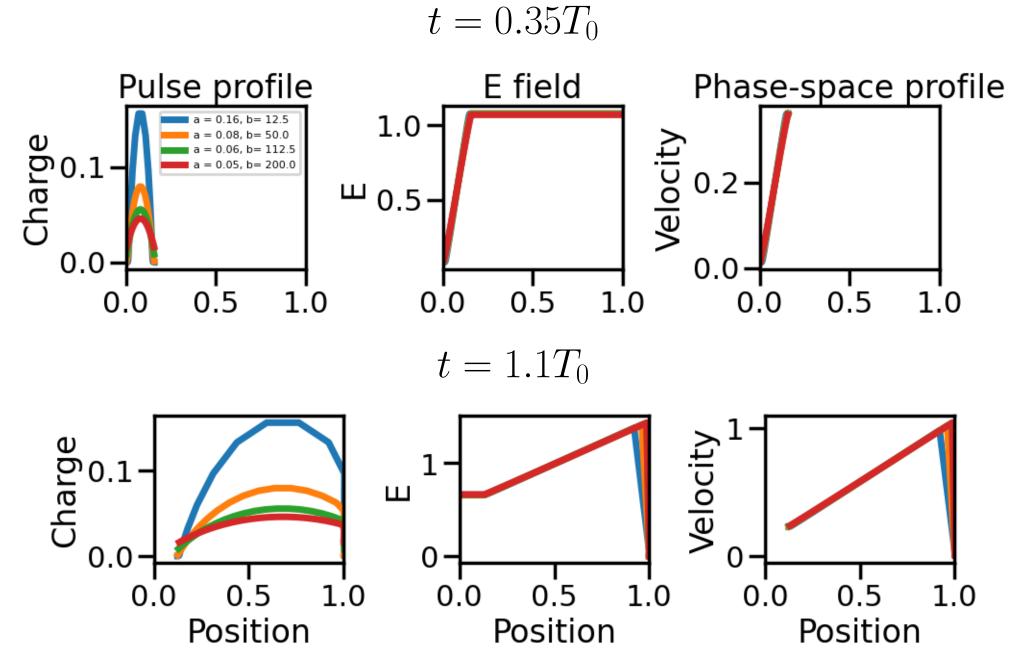


Figure 5: Evolution of pulse profile, electric field, and velocity for Case 1.

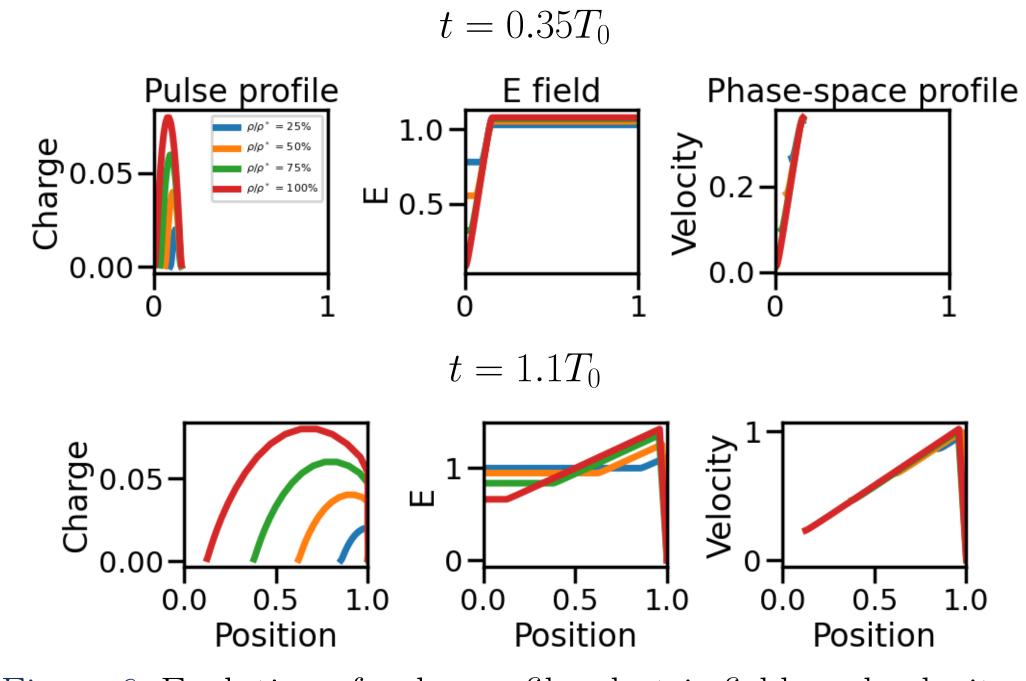


Figure 6: Evolution of pulse profile, electric field, and velocity for Case 2.

Algorithm 1 Calculation of distortion

Input: $M, \ \delta \bar{x}$

- 1: $\delta \bar{x}_{init} \leftarrow (M-1)\delta \bar{x}$
- $2: t \leftarrow 0$
- 3: while $\bar{x}_1(t) < 1$ do
- 4: $t \leftarrow t + 1$
- 5: end while
- 6: $\delta \bar{x}_{final} \leftarrow \bar{x}_1(t) \bar{x}_M(t)$
- 7: $\Delta \leftarrow \delta \bar{x}_{final}/\delta \bar{x}_{init}$
- 8: return Δ

Conclusion & Future Work

- For the same total charge all Gaussian pulses undergo similar distortion (fig. 5).
- 2 The shorter the pulse length, the more significant the distortion becomes.
- 3 The smaller the charge, the faster the tail of the pulse travels through the gap (fig. 6).
- 4 In future work, we will assess the Child-Langmuir limit as the pulse length decreases.

References & Acknowledgement

[1] C. Birdsall and W. Bridges (1966). Electron dynamics of diode regions. New York: Academic Press [2] P. Zhang et *al.*, Applied Physics Reviews 4, 011304 (2017).

[3] A. Valfells et *al.*, Physics of Plasmas 9(5), 2377-2382 (2002).

[4] C. Kaur et *al.*, Physical Review E 106(5-2), 055203 (2002).

Acknowledgement: Work is supported by the Office of Naval Research (ONR) YIP Grant No. N00014-20-1-2681, the Air Force Office of Scientific Research (AFOSR) Grant No. FA9550-20-1-0409, and the Air Force Office of Scientific Research (AFOSR) Award No. FA9550-22-1-0523

Download the poster:

https://tinyurl.com/2yka3v4h

